

October 2014

FDMD8280

Dual N-Channel Power Trench[®] MOSFET 80 V, 40 A, 8.2 m Ω

Features

- Max $r_{DS(on)}$ = 8.2 m Ω at V_{GS} = 10 V, I_D = 11 A
- Max $r_{DS(on)}$ = 11 m Ω at V_{GS} = 8 V, I_D = 9.5 A
- Ideal for flexible layout in primary side of bridge topology
- Termination is Lead-free and RoHS Compliant
- 100% UIL tested
- Kelvin High Side MOSFET drive pin-out capability

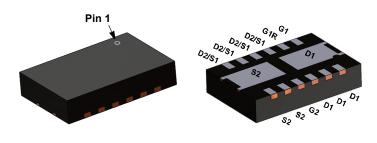


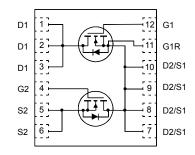
General Description

This device includes two 80V N-Channel MOSFETs in a dual Power (3.3 mm X 5 mm) package. HS source and LS Drain internally connected for half/full bridge, low source inductance package, low $r_{DS(on)}/Qg$ FOM silicon.

Applications

- Synchronous Buck : Primary Switch of Half / Full bridge converter for telecom
- Motor Bridge : Primary Switch of Half / Full bridge converter for BLDC motor
- MV POL: 48V Synchronous Buck Switch





Power 3.3 x 5

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parame	eter		Ratings	Units
V_{DS}	Drain to Source Voltage			80	V
V_{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous	T _C = 25 °C		40	
I_D	Drain Current -Continuous	T _A = 25 °C	(Note 1a)	11	Α
	-Pulsed		(Note 4)	160	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	150	mJ
	Power Dissipation	T _C = 25 °C		38	
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	2.1	W
	Power Dissipation	T _A = 25 °C	(Note 1b)	1	
T _J , T _{STG}	Operating and Storage Junction Tempera	ture Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.3	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note	a) 60	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note	b) 130	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
8280	FDMD8280	Power 3.3 x 5	13 "	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	80			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		48		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 64 V, V _{GS} = 0 V			1	μА
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	3.0	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25 °C		-9		mV/°C
		V _{GS} = 10 V, I _D = 11 A		6.6	8.2	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 8 \text{ V}, I_D = 9.5 \text{ A}$		7.5	11	mΩ
		V_{GS} = 10 V, I_{D} = 11 A, T_{J} = 125 °C		10	12.4	
9 _{FS}	Forward Transconductance	V _{DD} = 10 V, I _D = 11 A		29		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V - 40 V V - 0 V		2179	3050	pF
C _{oss}	Output Capacitance	V _{DS} = 40 V, V _{GS} = 0 V f = 1 MHz		341	480	pF
C _{rss}	Reverse Transfer Capacitance	- 1 - 1 WII 12		15	25	pF
R_q	Gate Resistance		0.1	2.7	5.4	Ω

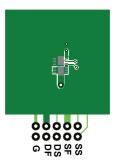
Switching Characteristics

t _{d(on)}	Turn-On Delay Time		V_{DD} = 40 V, I_{D} = 11 A V_{GS} = 10 V, R_{GEN} = 6 Ω		15	27	ns
t _r	Rise Time	V _{DD} = 40 V, I _D = 11			12	22	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN}$			26	42	ns
t _f	Fall Time				8.9	18	ns
0	Total Gate Charge	V _{GS} = 0 V to 10 V			31	44	nC
$Q_{g(TOT)}$	Total Gate Charge	V _{GS} = 0 V to 8 V	V _{DD} = 40 V		25	35	nC
Q_{gs}	Gate to Source Charge		I _D = 11 A		9.5		nC
Q_{gd}	Gate to Drain "Miller" Charge				6.6		nC

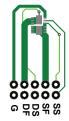
Drain-Source Diode Characteristics

V	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 11 \text{ A}$ (Note 2)	0.8	1.3	V
v_{SD}	Source to Drain Diode i orward voltage	$V_{GS} = 0 \text{ V}, I_S = 1.8 \text{ A}$ (Note 2)	0.7	1.2	
t _{rr}	Reverse Recovery Time	I _E = 11 A, di/dt = 100 A/μs	27	43	ns
Q _{rr}	Reverse Recovery Charge	n _F = 11 A, αι/αι = 100 A/μs	12	22	nC

^{1.} $R_{\theta,IA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta,IC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



a. 60 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 130 °C/W when mounted on a minimum pad of 2 oz copper

^{2.} Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0 %.

^{3.} E_{AS} of 150 mJ is based on starting T_J = 25 $^{\circ}$ C, L = 3 mH, I_{AS} = 10 A, V_{DD} = 72 V, V_{GS} = 10 V. 100% tested at L = 0.1 mH, I_{AS} = 32 A. 4. Pulse Id measured at td <= 250 μ s, refer to Fig 11 SOA graph for more details.

Typical Characteristics T_J = 25 °C unless otherwise noted

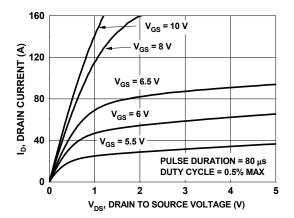


Figure 1. On-Region Characteristics

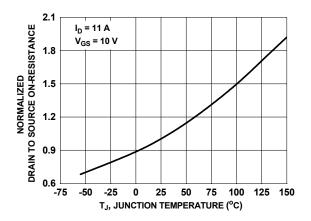


Figure 3. Normalized On Resistance vs Junction Temperature

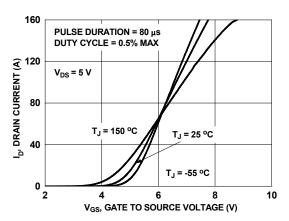


Figure 5. Transfer Characteristics

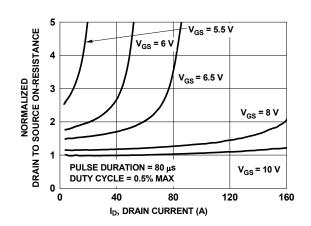


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

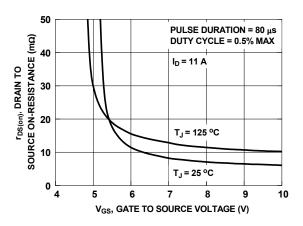


Figure 4. On Resistance vs Gate to Source Voltage

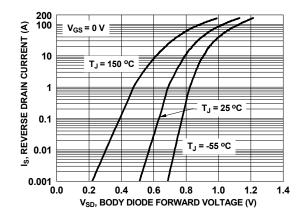


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25 °C unless otherwise noted

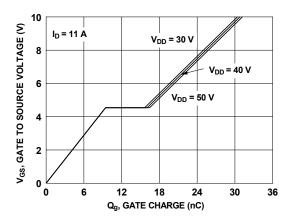


Figure 7. Gate Charge Characteristics

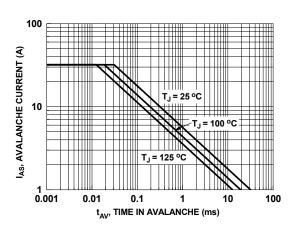


Figure 9. Gate Leakage Current vs Gate to Source Voltage

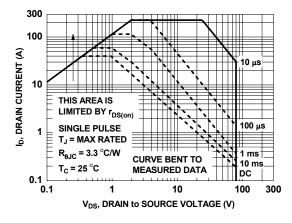


Figure 11. Forward Bias Safe Operating Area

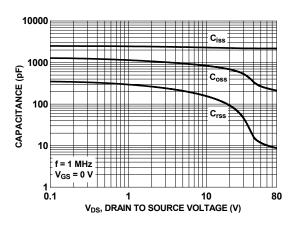


Figure 8. Capacitance vs Drain to Source Voltage

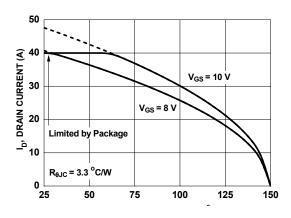


Figure 10. Maximum Continuous Drain Current vs Case Temperature

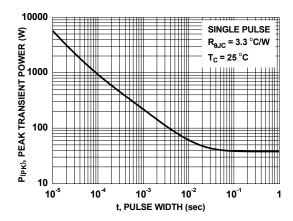


Figure 12. Single Pulse Maximum Power Dissipation



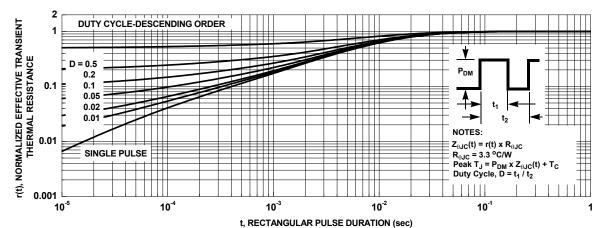
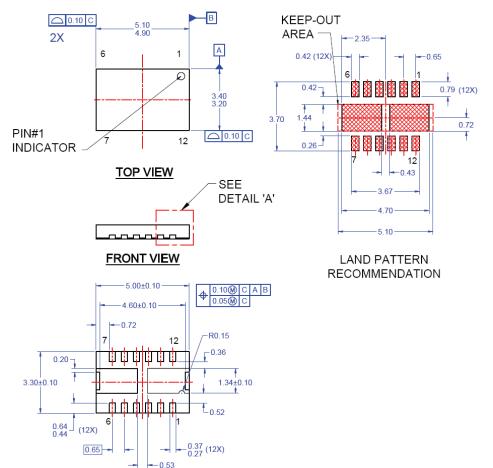


Figure 13. Junction-to-Case Transient Thermal Response Curve

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Dimensional Outline and Pad Layout



BOTTOM VIEW

0.80 0.70 0.10 C F 0.05 0.05 0.05 0.05 SEATING PLANE

NOTES: UNLESS OTHERWISE SPECIFIED

- A) DOES NOT FULLY CONFORM TO JEDEC REGISTRATION, MO-229 DATED 8/2012
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- E) IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.
- F) DRAWING FILE NAME: MKT-PQFN12BREV1

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